AUTOMOTIVE GRADE

International **ICR** Rectifier

AUIRFB8407 AUIRFS8407 AUIRFSL8407

Features

- Advanced Process Technology •
- New Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and wide variety of other applications.

Applications

- Electric Power Steering (EPS)
- **Battery Switch**
- Start/Stop Micro Hybrid
- Heavy Loads
- **DC-DC** Applications

Bebernpphoadono				
Ordering Information				
Base part number	Package Type	Standard Pack		Complete Part
		Form	Quantity	Number
AUIRFB8407	TO-220	Tube	50	AUIRFB8407
AUIRFSL8407	TO-262	Tube	50	AUIRFSL8407
AUIRFS8407	D2Pak	Tube	50	AUIRFS8407
AUIRFS8407	D2Pak	Tape and Reel Left	800	AUIRFS8407TRL

TO-220AB

AUIRFB8407

G

Gate

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolutemaximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T_A) is 25°C, unless otherwise specified

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	250①	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	180	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Wire Bond Limited)	195	A
I _{DM}	Pulsed Drain Current ②	1000®	
P _D @T _C = 25°C	Maximum Power Dissipation	230	W
	Linear Derating Factor	1.5	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw	10lbf· in (1.1N· m)	

Avalanche Characteristics

EAS (Thermally limited)	Single Pulse Avalanche Energy ③	350	mJ
E _{AS} (tested)	Single Pulse Avalanche Energy Tested Value ③	500	
I _{AR}	Avalanche Current ©	See Fig. 14, 15, 22a, 22b	А
E _{AR}	Repetitive Avalanche Energy ②		mJ

HEXFET® is a registered trademark of International Rectifier.

*Qualification standards can be found at http://www.irf.com/



typ.

40V

1.4m Ω

1.8mΩ

250A^①

195A

DS

G

VDSS

R_{DS(on)}

(SMD version) **max**

I_D (Silicon Limited)

D (Package Limited)

D



Static @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	40			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.029		V/°C	Reference to 25°C, I _D = 1mA [®]
R _{DS(on)} SMD			1.4	1.8		V _{GS} = 10V, I _D = 100A
R _{DS(on)} TO-220	Static Drain-to-Source On-Resistance		1.6	2.0	mΩ	$V_{GS} = 10V, I_{D} = 100A$
V _{GS(th)}	Gate Threshold Voltage	2.0	3.0	4.0	V	$V_{DS} = V_{GS}, I_D = 150 \mu A$
I _{DSS}	Drain-to-Source Leakage Current			1.0	μA	$V_{DS} = 40V, V_{GS} = 0V$
				150		$V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-100		$V_{GS} = -20V$
R _G	Internal Gate Resistance		2.2		Ω	

Dynamic @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
gfs	Forward Transconductance	160			S	V _{DS} = 10V, I _D = 100A
Q _q	Total Gate Charge		150	225	nC	I _D = 100A
Q _{gs}	Gate-to-Source Charge		41			V _{DS} =20V
Q _{gd}	Gate-to-Drain ("Miller") Charge	_	51			V _{GS} = 10V
Q _{sync}	Total Gate Charge Sync. (Q _g - Q _{gd})		99			$I_{D} = 100A, V_{DS} = 20V, V_{GS} = 10V$
t _{d(on)}	Turn-On Delay Time		19		ns	$V_{DD} = 20V$
t,	Rise Time		70			I _D = 30A
t _{d(off)}	Turn-Off Delay Time		78			$R_{G} = 2.7\Omega$
t _f	Fall Time		53			V _{GS} = 10V ⑤
C _{iss}	Input Capacitance		7330		pF	$V_{GS} = 0V$
C _{oss}	Output Capacitance	_	1095	_		$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		745			f = 1.0 MHz, See Fig. 5
C _{oss} eff. (ER)	Effective Output Capacitance (Energy Related) ⑦		1310			$V_{GS} = 0V, V_{DS} = 0V$ to 32V \textcircled{O} , See Fig. 11
C _{oss} eff. (TR)	Effective Output Capacitance (Time Related) ®		1735			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 32V $

Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current			250 ①	А	MOSFET symbol
	(Body Diode)					showing the
I _{SM}	Pulsed Source Current			1000®	А	integral reverse
	(Body Diode) ②					p-n junction diode.
V _{SD}	Diode Forward Voltage		1.0	1.3	V	T _J = 25°C, I _S = 100A, V _{GS} = 0V ⑤
dv/dt	Peak Diode Recovery ④		3.0		V/ns	T _J = 175°C, I _S = 100A, V _{DS} = 40V ⑤
t _{rr}	Reverse Recovery Time		30		ns	$T_J = 25^{\circ}C$ $V_R = 34V$,
			30			$T_{J} = 125^{\circ}C$ $I_{F} = 100A$
Q _r	Reverse Recovery Charge		24		nC	T _J = 25°C di/dt = 100A/μs ⑤
			25			T _J = 125°C
I _{RRM}	Reverse Recovery Current		1.3		А	$T_J = 25^{\circ}C$

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
R _{eJC}	Junction-to-Case ⑨		0.65	
R _{ecs}	Case-to-Sink, Flat Greased Surface, TO-220	0.50		°C/W
$R_{\theta JA}$	Junction-to-Ambient, TO-220 ⁽		62	C/VV
R _{θJA}	Junction-to-Ambient (PCB Mount) , D ² Pak ®		40	



Qualification Information[†]

Qualification Level		Automotive			
		(per AEC-Q101)			
		Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.			
		D2 PAK	MSL1		
Moisture Sensiti	Moisture Sensitivity Level		N/A		
		TO-262	IVA		
	Machine Model	Class M4 (+/- 800V) ^{††}			
		AEC-Q101-002			
500	Human Rady Madal		Class H2 (+/- 4000V) ^{††}		
ESD	Human Body Model	AEC-Q101-001			
	Charged Davies Made	Class C5 (+/- 2000V) ^{††}			
	Charged Device Model	AEC-Q101-005			
RoHS Compliant		Yes			

† Qualification standards can be found at International Rectifier's web site: http://www.irf.com/

†† Highest passing voltage

Notes:

- ① Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 195A by source bonding technology . Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements. (Refer to AN-1140)
- ② Repetitive rating; pulse width limited by max. junction temperature.
- ③ Limited by T_{Jmax}, starting T_J = 25°C, L = 0.069mH R_G = 25 Ω , I_{AS} = 100A, V_{GS} =10V.
- $\label{eq:ISD} \textcircled{0.5mu}{0.5mu} I_{SD} \leq 100 A, \ di/dt \leq 1166 A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^\circ C.$

- \bigcirc Pulse width \leq 400µs; duty cycle \leq 2%.
- \odot C_{oss} eff. (TR) is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- O C_{oss} eff. (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.
- $\circledast~R_{\theta}$ is measured at T_{J} approximately 90°C.
- $\ensuremath{\mathbb{O}}$ Pulse drain current is limited by source bonding technology.









 V_{GS} , Gate-to-Source Voltage (V)





Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

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Fig 2. Typical Output Characteristics







Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

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Fig 9. Maximum Drain Current vs. Case Temperature







Fig 8. Maximum Safe Operating Area



Fig 10. Drain-to-Source Breakdown Voltage







Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case



tav (sec) Fig 14. Typical Avalanche Current vs.Pulsewidth



Fig 15. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 14, 15: (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption:
 - Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{imax} . This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long asT_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 24a, 24b.
- 4. P_{D (ave)} = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. Δ T = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 14, 15).
 - t_{av =} Average time in avalanche.
 - $D = Duty cycle in avalanche = t_{av} \cdot f$

 $Z_{thJC}(D, t_{av}) = Transient thermal resistance, see Figures 13)$

$$\begin{split} \textbf{P}_{D \;(ave)} &= 1/2 \; (\; 1.3 \cdot \textbf{BV} \cdot \textbf{I}_{av}) = \Delta T / \; \textbf{Z}_{thJC} \\ \textbf{I}_{av} &= 2 \Delta T / \; [1.3 \cdot \textbf{BV} \cdot \textbf{Z}_{th}] \\ \textbf{E}_{AS \;(AR)} &= \textbf{P}_{D \;(ave)} \cdot \textbf{t}_{av} \end{split}$$



Fig 16. Typical On-Resistance vs. Gate Voltage



Fig. 18 - Typical Recovery Current vs. dif/dt



7

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Fig 17. Threshold Voltage vs. Temperature



Fig. 19 - Typical Stored Charge vs. dif/dt



Fig. 21 - Typical Stored Charge vs. di_f/dt



Fig 22. Typical On-Resistance vs. Drain Current

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* V_{GS} = 5V for Logic Level Devices





Fig 24a. Unclamped Inductive Test Circuit



Fig 25a. Switching Time Test Circuit



Fig 26a. Gate Charge Test Circuit



Fig 24b. Unclamped Inductive Waveforms



Fig 25b. Switching Time Waveforms



Fig 26b. Gate Charge Waveform

ld



TO-220AB Package Outline

Dimensions are shown in millimeters (inches)











NOTES:

- 1,-
- 2.-3.-4.-
- MURENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994. DMENSIONIS ARE SHOWN IN INCHES [MILLIMETERS]. LEAD DMENSION AND FINISH UNCONTROLLED IN L1. DMENSION D, D1 & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCED. JOS⁶ (JC127) PER SIDE. THESE DMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

- <u>/5,-</u> 6,-7,-
- DMENSION 61, 63 & c1 APPLY TO BASE METAL ONLY. CONTROLLING DIMENSION : INCHES. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1

8.-

THERMAL PAD CURUNG OF INDRAL, WITHIN DIMENSIONS ENTIDE & ET DIMENSION E 2 X HI DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITES ARE ALLOWED. OUTLINE CONFORMS TO JEDEC TO-220, EXCEPT A2 (mox.) AND D2 (min.) WHERE DIMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE OUTLINE. 9.-

SYMBOL	MILLIM	E TERS	INC	HES	
	Min.	MAX.	MIN.	MAX.	NOTES
A	3.56	4.83	.140	.190	
A1	0.51	1.40	.020	.055	
A2	2.03	2.92	.080	.115	
b	0.38	1.01	.015	.040	
b1	0.38	0.97	.015	.038	5
b2	1.14	1.78	.045	.070	
b3	1.14	1.73	.045	.068	5
с	0.36	0.61	.014	.024	
c1	0.36	0,56	.014	.022	5
D	14.22	16.51	.560	.650	4
D1	8.38	9.02	.330	.355	
D2	11.68	12.88	.460	.507	7
E	9.65	10.67	.380	.420	4,7
E1	6.86	8.89	.270	.350	7
E2	-	0,76	-	.030	8
e	2.54	BSC	.100	BSC	
e1	5.08	BSC	.200	BSC	
H1	5.84	6.86	.230	.270	7,8
L	12.70	14,73	.500	.580	
Lt	3.56	4.06	.140	.160	3
øP	3.54	4.08	.139	.161	
Q	2.54	3.42	.100	.135	

LEAD ASSIGNMENTS HEXFET 1.- GATE 2.- DRAIN 3.- SOURCE IGBTs CoPACK 1.- GATE 2.- Collector 3.- Emitter DIODES 1.- ANODE 2.- CATHODE 3.- ANODE

TO-220AB Part Marking Information



TO-220AB packages are not recommended for Surface Mount Application.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



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TO-262 Package Outline

Dimensions are shown in millimeters (inches)



- NOTES
- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- $\$ Dimension D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, LI, DI & EI.
- 5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.

6. CONTROLLING DIMENSION; INCH.

7.- OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

S Y M		DIMENSIONS					
M B O	MILLIM	ETERS	INC	O T E S			
L	Min,	MAX.	MIN,	MAX.	S		
Α	4.06	4,83	.160	.190			
A1	2.03	3.02	.080	.119			
b	0.51	0.99	.020	.039			
b1	0.51	0.89	.020	.035	5		
b2	1,14	1.78	.045	.070			
b3	1,14	1.73	.045	.068	5		
с	0.38	0.74	.015	.029			
c1	0.38	0.58	.015	.023	5		
c2	1,14	1.65	.045	.065			
D	8.38	9,65	.330	,380	3		
D1	6,86	-	.270	-	4		
Е	9.65	10.67	.380	.420	3,4		
E1	6.22	-	.245		4		
e	2.54 BSC		.100 BSC				
L	13,46	14.10	.530	.555			
L1	-	1.65	-	.065	4		
L2	3.56	3,71	,140	.146			

LEAD ASSIGNMENTS

<u>HEXFET</u>

1	GATE
2	DRAIN
3	SOURCE

4.- DRAIN

IGBTs, CoPACK

1.- GATE 2.- COLLECTOR 3.- EMITTER 4.- COLLECTOR

TO-262 Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



D²Pak (TO-263AB) Package Outline

Dimensions are shown in millimeters (inches)











NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- $\overrightarrow{\ }$ Dimension D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.

6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.

7. CONTROLLING DIMENSION: INCH.

8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S Y M			N		
В	MILLIM	ETERS	INC	HES	N O T E S
0 L	MIN.	MAX.	MIN.	MAX.	Š
Α	4.06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
b	0.51	0.99	.020	.039	
b1	0.51	0.89	.020	.035	5
b2	1.14	1.78	.045	.070	
bЗ	1.14	1.73	.045	.068	5
с	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	-	.270		4
Е	9.65	10.67	.380	.420	3,4
E1	6.22	-	.245		4
е	2.54	BSC	.100	.100 BSC	
н	14.61	15.88	.575	.625	
L	1.78	2,79	.070	.110	
L1	-	1.65	-	.066	4
L2	1.27	1.78	-	.070	
L3	0.25	BSC	.010	BSC	
L4	4.78	5.28	.188	.208	

LEAD ASSIGNMENTS

HEXFET 1.- GATE 2, 4.- DRAIN 3.- SOURCE

IGBTs, CoPACK 1.- GATE

2, 4,- COLLECTOR 3.- EMITTER

DIODES

1.- ANODE * 2, 4.- CATHODE 3.- ANODE

* PART DEPENDENT.

D²Pak (TO-263AB) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



D²Pak (TO-263AB) Tape & Reel Information Dimensions are shown in millimeters (inches)



Note: For the most current drawing please refer to IR website at: <u>http://www.irf.com/package/</u>

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